

# **FDP12N50 / FDPF12N50T** N-Channel UniFET<sup>TM</sup> MOSFET 500 V, 11.5 A, 650 mΩ

### Features

- $R_{DS(on)}$  = 550 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 6 A
- Low Gate Charge (Typ. 22 nC)
- Low C<sub>rss</sub> (Typ. 11 pF)
- 100% Avalanche Tested
- RoHS Compliant

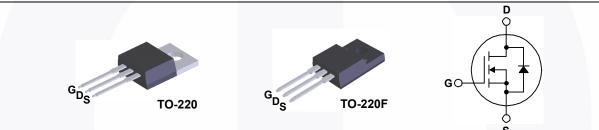
## Applications

- LCD/LED/PDP TV
- Lighting
- Uninterruptible Power Supply

November 2013

## Description

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.



### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter				FDPF12N50T	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			500		V	
V <sub>GSS</sub>	Gate to Source Voltage		±30		V		
	DrainCurrent	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)		11.5	11.5 *	•	
ID		- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		6.9	6.9 *	A	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	46	46 *	А	
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		456		mJ		
I <sub>AR</sub>	Avalanche Current		(Note 1)	11.5		А	
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	16.7		mJ	
dv/dt	Peak Diode Recovery dv	/dt	(Note 3)	4.5		V/ns	
D	Dower Dissinction	(T <sub>C</sub> = 25°C)		165	42	W	
P <sub>D</sub>	Power Dissipation	- Derate Above 25°C		1.33	0.3	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150		°C		
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			3	00	°C	

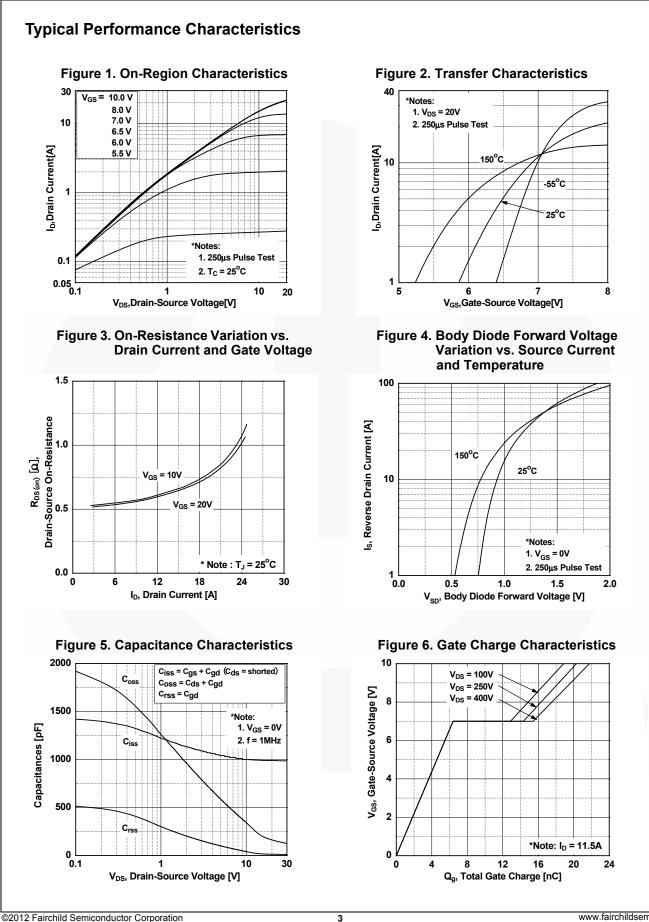
\*Drain current limited by maximum junction temperature

### **Thermal Characteristics**

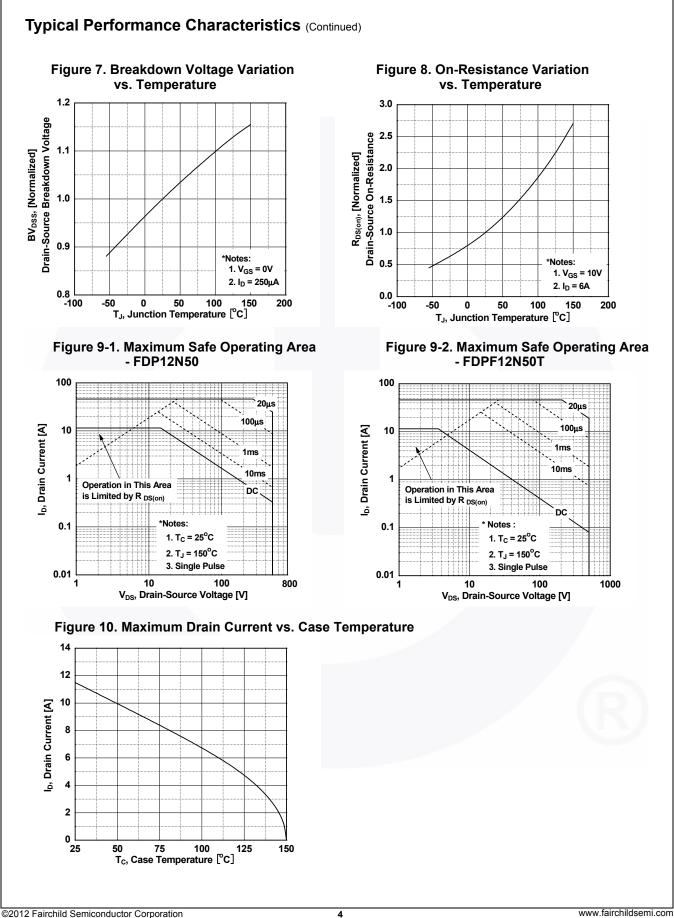
Symbol	Parameter	FDP12N50	FDPF12N50T	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.75	3.0	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	62.5	°C/W

FDP12N50 FDP12N50 T0		Package	O-220 Tube N/A		Тар	e Width	Qua	ntity	
		TO-220			N/A N/A		50 units 50 units		
		TO-220F							
Electrica	al Chara	acteristics T <sub>C</sub> = 2	5ºC unless	otherwise noted.					
Symbol		Parameter		Test Condition	ons	Min.	Тур.	Max.	Unit
Off Charad	cteristics	3							
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage		ige	$I_D = 250 \ \mu A, V_{GS} = 0 \ V, T_J = 25^{\circ}C$ $I_D = 250 \ \mu A, Referenced to 25^{\circ}C$		500	-	-	V
$\Delta BV_{DSS}$ / $\Delta T_J$						-	0.5	-	V/°C
	Zara Ca	ta Valtaga Drain Current		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V	'	-	-	1	
IDSS	Zero Ga	te Voltage Drain Current		$V_{DS} = 400 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$		-	-	10	μA
I <sub>GSS</sub>	Gate to I	Body Leakage Current		$V_{GS}$ = ±30 V, $V_{DS}$ = 0 V	'	-	-	±100	nA
On Charac	cteristics	3							
V <sub>GS(th)</sub>	Gate Th	reshold Voltage		V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	\	3.0	-	5.0	V
R <sub>DS(on)</sub>		rain to Source On Resista	ance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		-	0.55	0.65	Ω
9 <sub>FS</sub>	Forward	Transconductance		$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		-	11.5	-	S
Dynamic (	Characte	ristics							
C <sub>iss</sub>	1	pacitance				-	985	1315	pF
C <sub>oss</sub>	-	Capacitance		$-V_{DS} = 25 V, V_{GS} = 0 V,$		-	140	190	pF
				f = 1 MHz	-				-
	Reverse	Transfer Capacitance				-	11	17	pF
C <sub>rss</sub>		Transfer Capacitance te Charge at 10V	_		А,	-	11 22	17 30	pF nC
C <sub>rss</sub> Q <sub>g</sub>	Total Ga			V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5 V <sub>GS</sub> = 10 V	A,	-			
C <sub>rss</sub> Q <sub>g</sub> Q <sub>gs</sub>	Total Ga Gate to S	te Charge at 10V		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5	A, (Note 4)	- - -	22		nC
C <sub>rss</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total Ga Gate to S Gate to I	te Charge at 10V Source Gate Charge Drain "Miller" Charge		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5		-	22 6	30 -	nC nC
C <sub>rss</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Switching	Total Ga Gate to S Gate to I Charact	te Charge at 10V Source Gate Charge Drain "Miller" Charge		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5		- - - -	22 6	30 -	nC nC
C <sub>rss</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Switching	Total Ga Gate to S Gate to I Charact Turn-On	te Charge at 10V Source Gate Charge Drain "Miller" Charge		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5 V <sub>GS</sub> = 10 V V <sub>DD</sub> = 250 V, I <sub>D</sub> = 11.5	(Note 4)		22 6 9	30 - -	nC nC nC
$\begin{array}{c} C_{rss} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \\ \hline \textbf{Switching} \\ t_{d(on)} \\ t_{r} \\ \hline t_{r} \\ \hline t_{r} \\ \hline \end{array}$	Total Ga Gate to S Gate to I Charact Turn-On Turn-On	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5 V <sub>GS</sub> = 10 V	(Note 4)		22 6 9 24	30 - - 60	nC nC nC nC
$\frac{C_{rss}}{Q_{g}}$ $\frac{Q_{gs}}{Q_{gd}}$ Switching $t_{d(on)}$	Total Ga Gate to S Gate to I Charact Turn-On Turn-On Turn-Off	te Charge at 10V Source Gate Charge Drain "Miller" Charge <b>teristics</b> Delay Time Rise Time		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5 V <sub>GS</sub> = 10 V V <sub>DD</sub> = 250 V, I <sub>D</sub> = 11.5	(Note 4)		22 6 9 24 50	30 - - 60 110	nC nC nC nC nS ns
$\begin{array}{c} C_{rss} \\ \hline Q_g \\ \hline Q_{gs} \\ \hline Q_{gd} \\ \hline \\ $	Total Ga Gate to S Gate to I Charact Turn-On Turn-Off Turn-Off	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time Rise Time Delay Time Fall Time		V <sub>DS</sub> = 400 V, I <sub>D</sub> = 11.5 V <sub>GS</sub> = 10 V V <sub>DD</sub> = 250 V, I <sub>D</sub> = 11.5	(Note 4)	-	22 6 9 24 50 45	30 - - 60 110 100	nC nC nC nC nS ns
$\begin{array}{c} C_{rss} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \hline \\ Switching \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ \hline \\ Drain-Sou \\ \hline \end{array}$	Total Ga Gate to S Gate to I Charact Turn-On Turn-Off Turn-Off	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time Rise Time Delay Time	Jurce Diode	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}$ $V_{DD} = 250 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 25 \Omega$	(Note 4)	-	22 6 9 24 50 45	30 - - 60 110 100 70	nC nC nC nC nS ns
$\begin{array}{c} C_{rss} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \hline \\ Switching \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ \hline \\ Drain-Sou \\ l_{s} \\ \hline \end{array}$	Total Ga Gate to S Gate to I Charact Turn-On Turn-Off Turn-Off Turn-Off Itrce Diod	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time Rise Time Delay Time Fall Time e Characteristics		$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}$ $V_{DD} = 250 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 25 \Omega$ Forward Current	(Note 4)	-	22 6 9 24 50 45	30 - - 60 110 100	nC nC nC nS ns ns ns
C <sub>rss</sub> Q <sub>g</sub> Q <sub>gs</sub> Switching t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Drain-Sou I <sub>S</sub>	Total Ga Gate to S Gate to I Charact Turn-On Turn-Off Turn-Off Turn-Off Itrce Diod Maximun Maximun	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time Rise Time Delay Time Fall Time Ie Characteristics n Continuous Drain to Sc	Diode For	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}$ $V_{DD} = 250 \text{ V}, \text{ I}_{D} = 11.5 \text{ A}$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 25 \Omega$ Forward Current ward Current	(Note 4)	- - - -	22 6 9 24 50 45	30 - - 60 110 100 70 11.5	nC nC nC nS ns ns ns A
$\begin{array}{c} C_{rss} \\ Q_{g} \\ Q_{gs} \\ Q_{gd} \\ \hline \\ Switching \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \\ \hline \\ Drain-Sou \\ l_{s} \\ \hline \end{array}$	Total Ga Gate to S Gate to I Charact Turn-On Turn-Off Turn-Off Turn-Off Maximun Maximun Drain to S	te Charge at 10V Source Gate Charge Drain "Miller" Charge teristics Delay Time Rise Time Delay Time Fall Time Ie Characteristics In Continuous Drain to Source	Diode For	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}$ $V_{DD} = 250 \text{ V}, \text{ I}_{D} = 11.5$ $V_{GS} = 10 \text{ V}, \text{ R}_{G} = 25 \Omega$ Forward Current	(Note 4)	• • • •	22 6 9 24 50 45	30 - - 60 110 100 70 11.5 46	nC nC nC ns ns ns ns A A

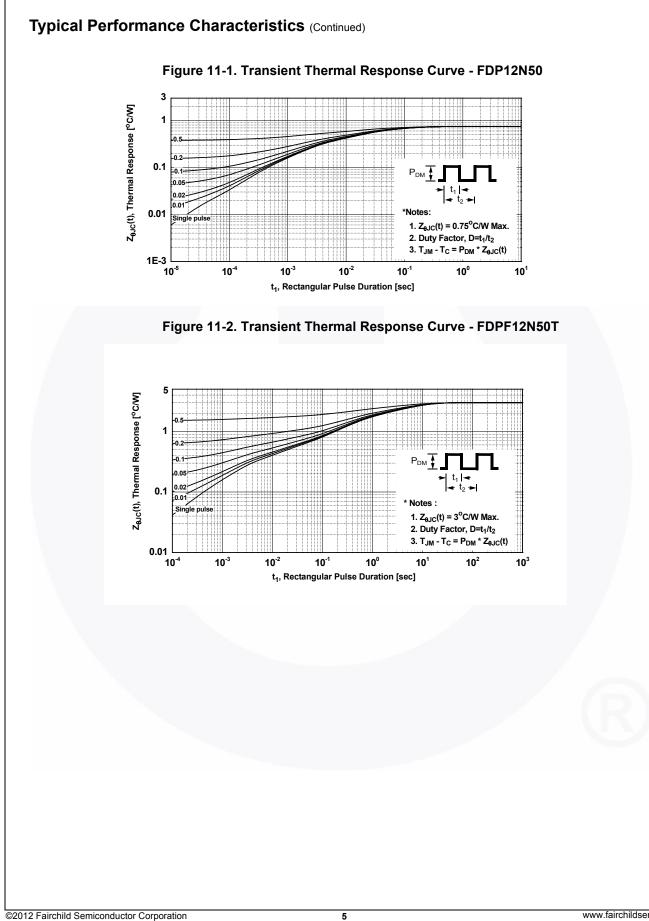
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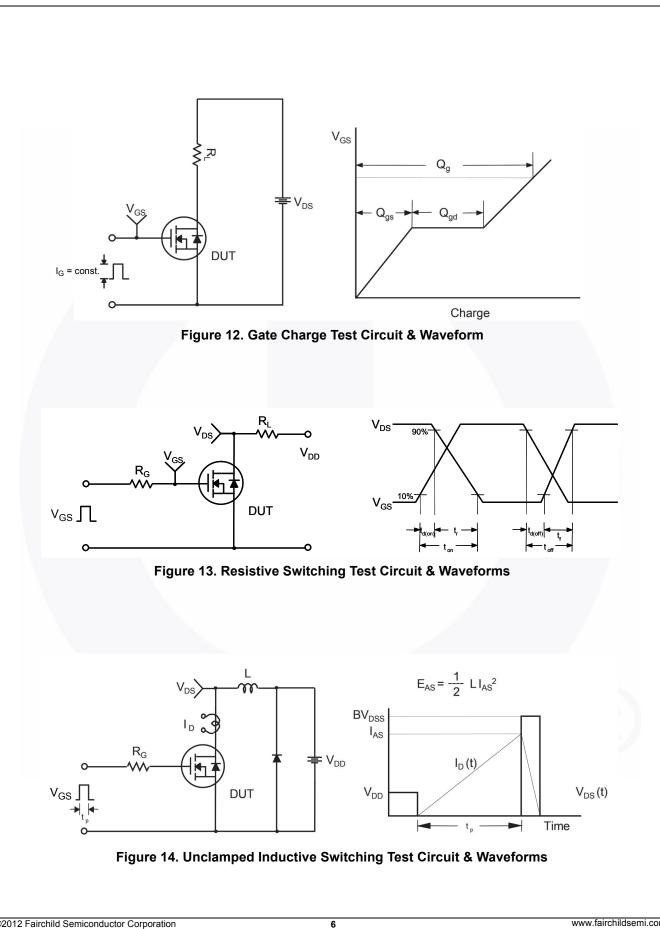


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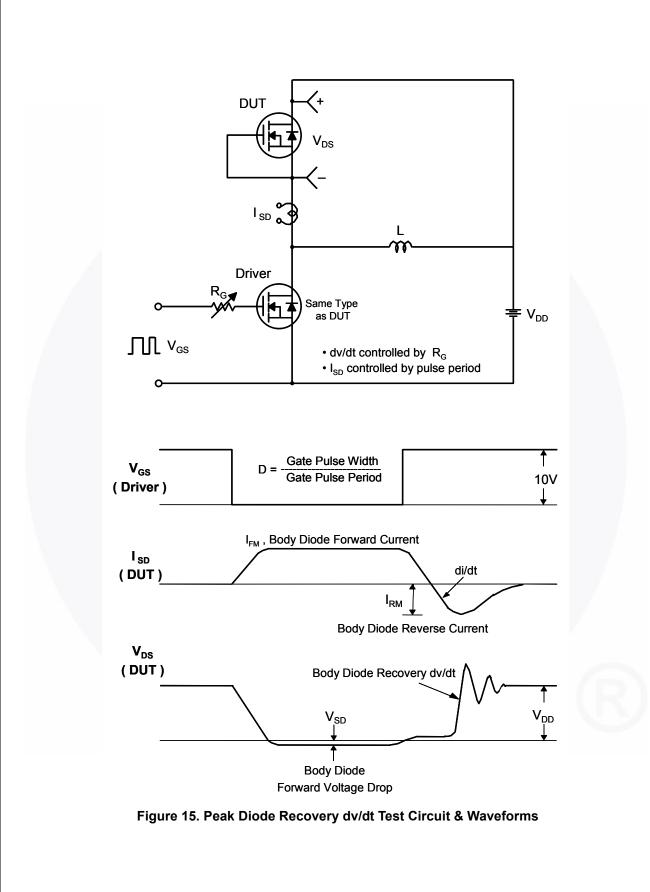


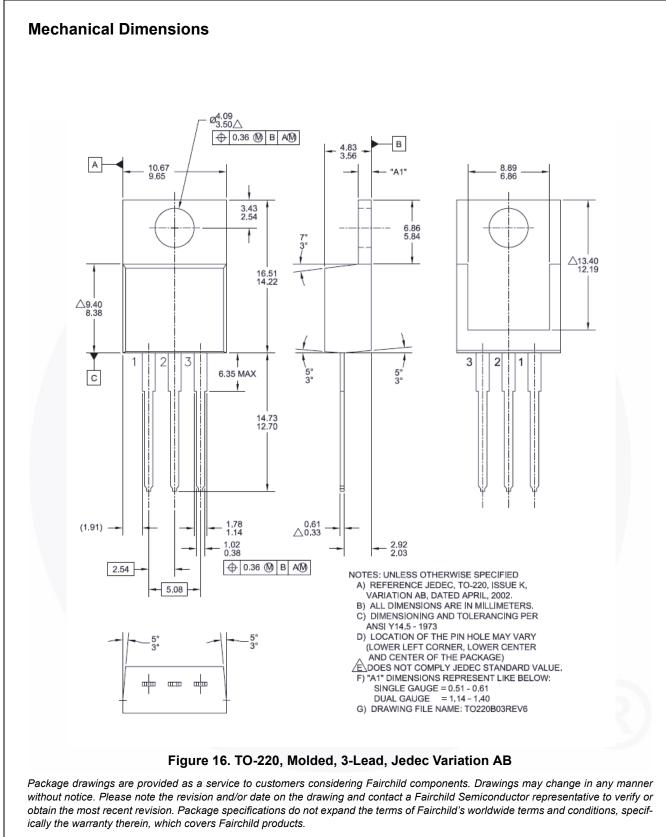
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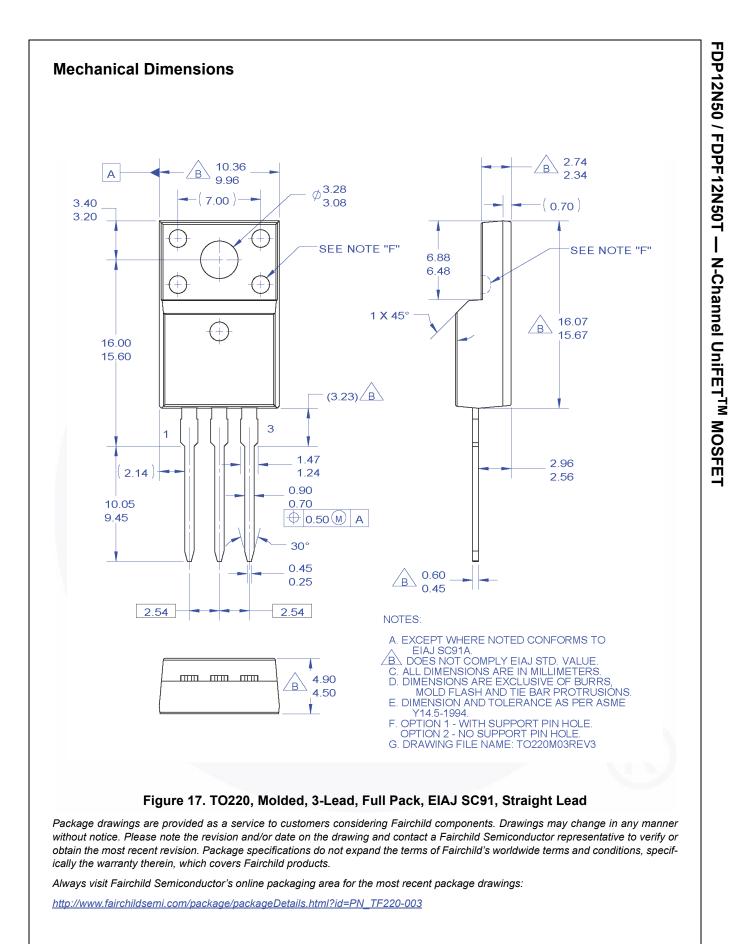




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